

<b>Notice of References Cited</b>	Application/Control No. 10/699,613		Applicant(s)/Patent Under Reexamination DELEULE, ARNAUD	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0144582	06-2005	Venkatraman et al.	716/010
*	B	US-2004/0064801	04-2004	Venkatraman et al.	716/021
*	C	US-2002/0006676	01-2002	Debenham et al.	438/14
*	D	US-6,559,544	05-2003	Roth et al.	257/758
*	E	US-6,514,780	02-2003	Manyoki, Zoltan	438/18
*	F	US-6,365,421	04-2002	Debenham et al.	438/14
*	G	US-6,194,738	02-2001	Debenham et al.	257/48
*	H	US-6,190,972	02-2001	Zheng et al.	438/275
*	I	US-5,895,962	04-1999	Zheng et al.	257/529
*	J	US-5,787,012	07-1998	Levitt, Marc E.	716/1
*	K	US-2003/0013025	01-2003	Tawara et al.	430/20
*	L	US-2002/0015898	02-2002	Sung et al.	430/5
*	M	US-2001/0013658	08-2001	Manyoki, Zoltan	257/758

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11224278 A	08-1999	Japan	YAMANO, MASAKAZU	G06F 17/50
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
	X	

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	Examiner Phallaka Kik	Art Unit 2825	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,629,239	09-2003	Steele, Jr., Guy L.	712/300
*	B	US-5,654,588	08-1997	Dasse et al.	257/754
*	C	US-5,594,273	01-1997	Dasse et al.	257/620
*	D	US-5,504,369	04-1996	Dasse et al.	257/620
*	E	US-5,399,505	03-1995	Dasse et al.	438/17
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	S					
	T					

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